

Search Notes

Application/Control No.

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Examiner

Ellen Kim

Applicant(s)/Patent under
Reexamination

HAYAMI ET AL.

Art Unit

2874

SEARCHED

Class	Subclass	Date	Examiner
385	137-138	10/28/2005	EK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
385	137-138	10/28/2005	EK

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	10/28/2005	EK